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"Low Side Chopper" IGBT SOT-227 (Ultrafast IGBT), 50 A



PRODUCT SUMMARY						
V _{CES}	1200 V					
I _C DC	50 A at 92 °C					
V _{CE(on)} typical at 50 A, 25 °C	3.3 V					
Package	SOT-227					
Circuit	Chopper low side switch					

FEATURES

- NPT Generation V IGBT technology
- Square RBSOA
- HEXFRED® clamping diode
- Positive V_{CE(on)} temperature coefficient
- · Fully isolated package
- Speed 8 kHz to 60 kHz
- Very low internal inductance (≤ 5 nH typical)
- · Industry standard outline
- UL approved file E78996



• Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

BENEFITS

- Designed for increased operating efficiency in power conversion: UPS, SMPS, welding, induction heating
- Easy to assemble and parallel
- · Direct mounting on heatsink
- Plug-in compatible with other SOT-227 packages
- · Low EMI, requires less snubbing

PARAMETER	SYMBOL	TEST CONDITIONS	MAX.	UNITS	
Collector to emitter voltage	V _{CES}		1200	V	
On the consultant of the consu	1	T _C = 25 °C	84		
Continuous collector current	I _C	T _C = 80 °C	57		
Pulsed collector current	I _{CM}		150		
Clamped inductive load current	I _{LM}		150	А	
Diode continuous forward current	I _F	T _C = 25 °C	87		
		T _C = 80 °C	59	1	
Single pulse forward current	I _{FSM}	10 ms sine or 6 ms rectangular pulse, T _J = 25 °C	310		
Gate to emitter voltage	V_{GE}		± 20	V	
Power dissipation, IGBT	P _D	T _C = 25 °C	431		
		T _C = 80 °C	242	1 ,,,	
Power dissipation, diode	В	T _C = 25 °C	338	W	
	P _D	T _C = 80 °C	190	7	
RMS isolation voltage	V _{ISOL}	Any terminal to case, t = 1 min	2500	V	



ELECTRICAL SPECIFICATIONS (T _J = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	L TEST CONDITIONS		TYP.	MAX.	UNITS	
Collector to emitter breakdown voltage	V _{BR(CES)}	$V_{GE} = 0 \text{ V}, I_C = 500 \mu\text{A}$	1200	-	-		
	V _{CE(on)}	$V_{GE} = 15 \text{ V}, I_{C} = 25 \text{ A}$	-	2.5	2.8		
Callector to amittar valtage		$V_{GE} = 15 \text{ V}, I_{C} = 50 \text{ A}$	-	3.3	-		
Collector to emitter voltage		$V_{GE} = 15 \text{ V}, I_{C} = 25 \text{ A}, T_{J} = 125 ^{\circ}\text{C}$	-	3.0	-	V	
		V _{GE} = 15 V, I _C = 50 A, T _J = 125 °C	-	4.03	-		
Gate threshold voltage	V _{GE(th)}	$V_{CE} = V_{GE}, I_{C} = 500 \mu A$	4.0	5.5	7.1		
Temperature coefficient of threshold voltage	V _{GE(th)} /ΔT _J	V _{CE} = V _{GE} , I _C = 1 mA (25 °C to 125 °C)	-	-12.9	-	mV/°C	
Callegtor to amittar leakage arrang	I _{CES}	V _{GE} = 0 V, V _{CE} = 1200 V	-	8	50	μΑ	
Collector to emitter leakage current		V _{GE} = 0 V, V _{CE} = 1200 V, T _J = 125 °C	-	0.15	-	mA	
Diode reverse breakdown voltage	V_{BR}	I _R = 1 mA	1200	-	-	V	
Diode forward voltage drop	V _{FM}	I _F = 25 A, V _{GE} = 0 V	-	2.11	2.42		
		I _F = 50 A, V _{GE} = 0 V	-	2.72	-		
		I _F = 25 A, V _{GE} = 0 V, T _J = 125 °C	-	2.04	-		
		I _F = 50 A, V _{GE} = 0 V, T _J = 125 °C	-	2.83	-		
District and below a small	I _{RM}	V _R = 1200 V	-	4	50	μΑ	
Diode reverse leakage current		T _J = 125 °C, V _R = 1200 V	-	0.8	-	mA	
Gate to emitter leakage current	I _{GES}	V _{GE} = ± 20 V	-	-	± 200	nA	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNITS
Total gate charge (turn-on)	Qg	I _C = 50 A, V _{CC} = 600 V, V _{GE} = 15 V		-	400	-	
Gate to emitter charge (turn-on)	Q _{ge}			-	43	-	nC
Gate to collector charge (turn-on)	Q _{gc}			=	187	-	
Turn-on switching loss	E _{on}	I _C = 50 A, V _{CC} = 600 V,		=	1.87	-	mJ ns
Turn-off switching loss	E _{off}	$V_{GE} = 15 \text{ V}, R_g = 4.7 \Omega,$		-	0.83	-	
Total switching loss	E _{tot}	L = 500 μH, T _J = 25 °C		-	2.7	-	
Turn-on switching loss	E _{on}	I _C = 50 A, V _{CC} = 600 V,	Energy losses include tail and diode recovery	-	3.43	-	
Turn-off switching loss	E _{off}			-	1.29	-	
Total switching loss	E _{tot}			=	4.72	-	
Turn-on delay time	t _{d(on)}	$V_{GE} = 15 \text{ V}, R_g = 4.7 \Omega,$		=	147	-	
Rise time	t _r	L = 500 μH, T _J = 125 °C		-	35	-	
Turn-off delay time	t _{d(off)}			=	186	-	
Fall time	t _f			-	119	-	
Reverse bias safe operating area	RBSOA	T_J = 150 °C, I_C = 150 A, R_g = 22 Ω , V_{GE} = 15 V to 0 V, V_{CC} = 900 V, V_P = 1200 V		Fullsquare			
Diode reverse recovery time	t _{rr}	I _F = 50 A, dI _F /dt = 200 A/μs, V _R = 200 V		=	129	=	ns
Diode peak reverse current	I _{rr}			-	11	-	Α
Diode recovery charge	Q _{rr}			-	710	-	nC
Diode reverse recovery time	t _{rr}	I _F = 50 A, dI _F /dt = 200 A/μs, V _R = 200 V, T _J = 125 °C		=	208	=	ns
Diode peak reverse current	I _{rr}			-	17	-	Α
Diode recovery charge	Q _{rr}			_	1768	-	nC



THERMAL AND MECHANICAL SPECIFICATIONS							
PARAMETER		SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Junction and storage tem	perature range	T _J , T _{Stg}		-40	-	150	°C
Junction to case	IGBT	D		-	-	0.29	
Junction to case	Diode	R _{thJC}		-	-	0.37	°C/W
Case to heatsink		R _{thCS}	Flat, greased surface	-	0.05	-	
Weight				-	30	-	g
Mounting torque			Torque to terminal	-	-	1.1 (9.7)	Nm (lbf.in)
			Torque to heatsink	-	-	1.3 (11.5)	Nm (lbf.in)
Case style			(SOT-227			

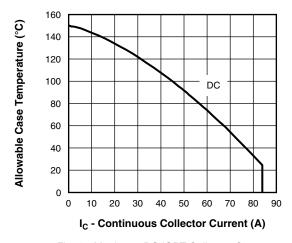


Fig. 1 - Maximum DC IGBT Collector Current vs.

Case Temperature

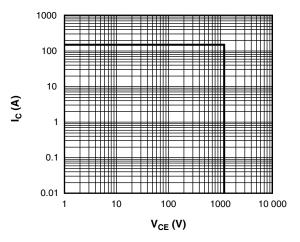


Fig. 2 - IGBT Reverse Bias SOA $T_J = 150$ °C, $V_{GE} = 15$ V

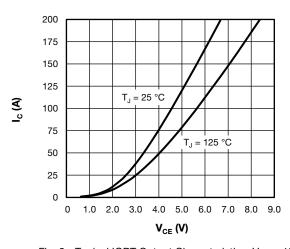


Fig. 3 - Typical IGBT Output Characteristics, $V_{\text{GE}} = 15V$

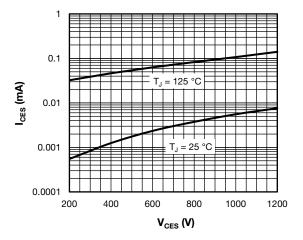


Fig. 4 - Typical IGBT Zero Gate Voltage Collector Current

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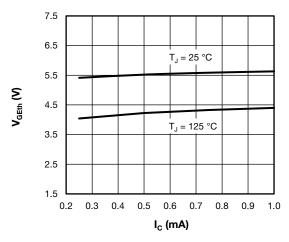


Fig. 5 - Typical IGBT Threshold Voltage

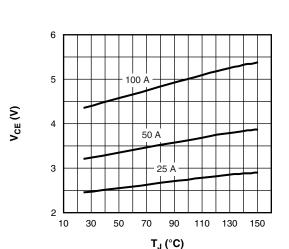


Fig. 6 - Typical IGBT Collector to Emitter Voltage vs. Junction Temperature, V_{GE} = 15 V

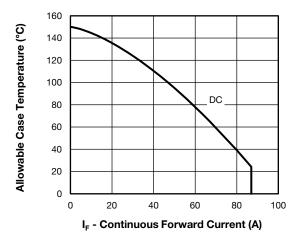


Fig. 7 - Maximum Diode Continuous Forward Current vs.
Case Temperature

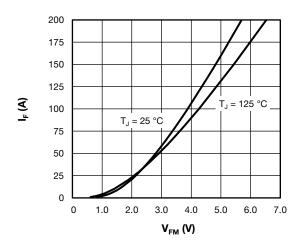


Fig. 8 - Typical Diode Forward Characteristics

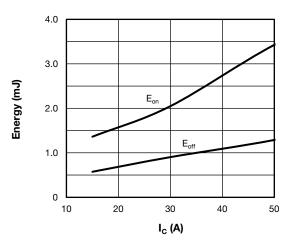


Fig. 9 - Typical IGBT Energy Losses vs. I $_{C}$ T $_{J}$ = 125 °C, V $_{CC}$ = 600 V, V $_{GE}$ = 15 V, L = 500 μ H, R $_{g}$ = 4.7 Ω

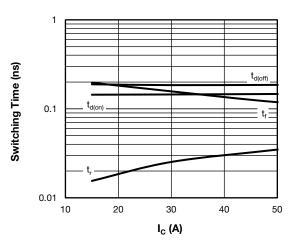


Fig. 10 - Typical IGBT Switching Time vs. I_C T_J = 125 °C, V_{CC} = 600 V, V_{GE} = 15 V, L = 500 $\mu H,~R_g$ = 4.7 Ω

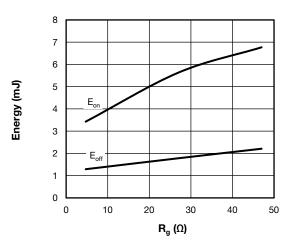


Fig. 11 - Typical IGBT Energy Losses vs. R_g T_J = 125 °C, I_C = 50 A, V_{CC} = 600 V, V_{GE} = 15 V, L = 500 μH

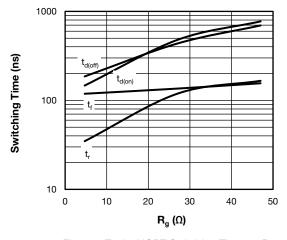


Fig. 12 - Typical IGBT Switching Time vs. R_g T_J = 125 °C, I_C = 50 A, V_{CC} = 600 V, V_{GE} = 15 V, L = 500 μH

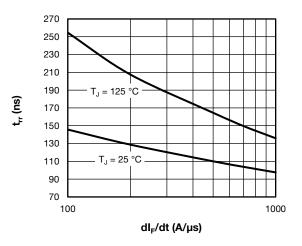


Fig. 13 - Typical t_{rr} Diode vs. dI_F/dt $V_R = 200 \text{ V}, I_F = 50 \text{ A}$

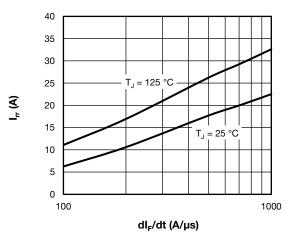


Fig. 14 - Typical I_{rr} Diode vs. dI_F/dt $V_R = 200$ V, $I_F = 50$ A

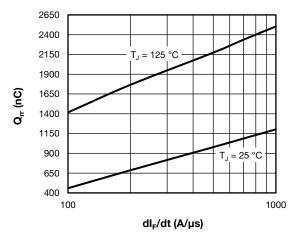


Fig. 15 - Typical Q_{rr} Diode vs. dI_F/dt , $V_R = 200 \text{ V}$, $I_F = 50 \text{ A}$

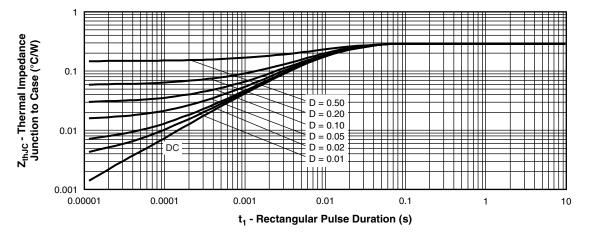


Fig. 16 - Maximum Thermal Impedance Z_{thJC} Characteristics (IGBT)

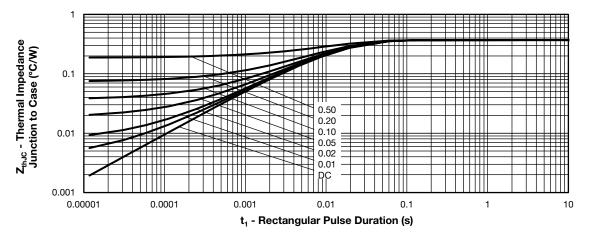
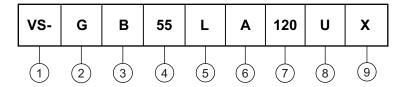


Fig. 17 - Maximum Thermal Impedance Z_{thJC} Characteristics (Diode)



ORDERING INFORMATION TABLE

Device code



1 - Vishay Semiconductors product

- Insulated Gate Bipolar Transistor (IGBT)

B = IGBT Generation 5

- Current rating (55 = 50 A)

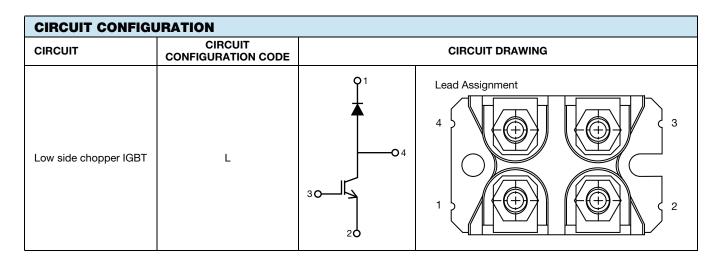
Circuit configuration (L = low side chopper)

- Package indicator (A = SOT-227)

7 - Voltage rating (120 = 1200 V)

- Speed/type (U = ultrafast IGBT)

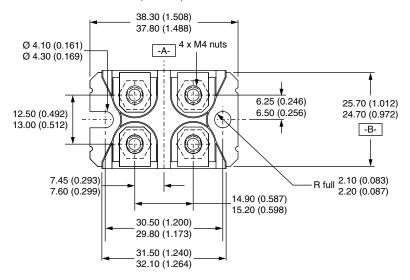
Diode (X = HEXFRED[®] diode)

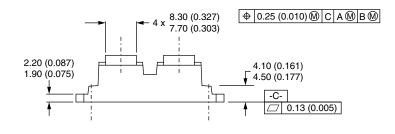


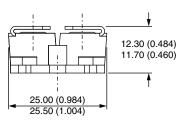
LINKS TO RELATED DOCUMENTS					
Dimensions <u>www.vishay.com/doc?95423</u>					
Packaging information	www.vishay.com/doc?95425				



DIMENSIONS in millimeters (inches)



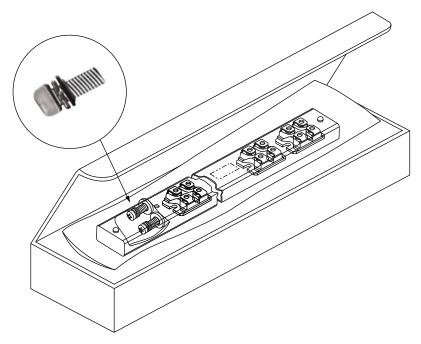




Note

· Controlling dimension: millimeter

PACKAGING INFORMATION





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